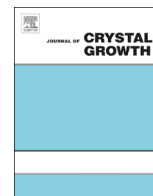




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# Formation of copper porous structures under near-equilibrium chemical vapor deposition



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## ABSTRACT

The mechanism of copper structure formation under near-equilibrium conditions in a chemically-active medium-condensate system has been investigated. The desired conditions have been implemented using CVD system. Copper chloride  $\text{CuCl}_2$  was used as a source material, and mixture of hydrogen with nitrogen served as a working gas. The influence of the evaporation temperature, condensation temperature and state of the growth surface on the porous structures formation has been investigated. It has been established, that the structure formation mechanism is determined by layer-by-layer or normal crystal growth, nucleation and growth of whiskers, and also by partial intergrowth of structural elements.

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## 1. Introduction

Depending on structural and morphological characteristics porous structures and nanoparticles systems have great potential for application as catalysts [1–5], sensors [6–10], electrodes in electrochemical batteries [11–14], solar cells [15], fuel cells [16] and other active elements. Different methods are used with the purpose to form nanoparticles systems with uniform size and shape. Among them homogeneous nucleation from supersaturated vapors [17–22] and colloidal self-assembly [23,24]. Alumina membranes are widely used in order to form ordered nanoparticles arrays on the substrate [25–28].

One of the most widespread method of nanoporous metal structures formation is dealloying process, which consist in selective chemical or electrochemical etching of a desired component from its alloy [29–34]. Also porous metal nanosystems can be synthesized using a template with desired pore structure. After the cavities in the template are filled with a metal, the template material is removed [35,36].

Thus, the conventional methods of metal nanosystems synthesis in the form of ordered nanoparticles or nanoporous structures utilize rather complicated multistage processes. Our previous works [37–40] have shown that, self-assembling of ordered nanoparticles system or

nanoporous structures can be implemented under near-equilibrium condensation conditions in the plasma-condensate system. It has been established, that the nucleation occurs only on the limited amount of active centers. In this case, the free energy minimization together with Ostwald ripening determine the monodispersity of the nanoparticles shape and size on the nucleation stage [41–44]. The more prolonged condensation results in the porous structures growth which is caused by an incomplete intergrowth of newly formed nanoparticles [45,37–39].

The analysis of literature reviews has shown that the technology of nanoporous metal structures self-assembling is at the early stage of its development. It is not mentioned even in quite recent reviews [46]. In order to provide an effective performance of the technologies operating near-equilibrium, three problems have to be solved: implementation of technological conditions for metals condensation at critically small supersaturations; realization of steady-state condensation conditions which allow to obtain reproducible structural and morphological characteristics; investigation of the interdependence between the process technological parameters and the structure formation mechanisms.

It is known that metals are bad-volatile substances having a low value of the equilibrium pressure. This fact complicates near-equilibrium conditions implementation. Obviously, under such conditions, the depositing vapor pressure should be of the same order as the equilibrium pressure. For the majority of metals (except Mg, Zn, Cd and Hg [47]) the equilibrium pressure does not exceed  $10^{-5}$  Pa even for high temperatures. The realization of near-equilibrium conditions also requires deposition of extremely

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weak vapor fluxes. All these together, make it hard to control such weak fluxes and obtain reproducible results.

The equilibrium pressure can be increased conventionally by an increase in re-evaporation processes intensity. One solution is to influence by plasma onto the growth surface. In this case, the re-evaporation is enhanced not only by plasma heating, but also by direct energy transfer from the plasma particles to adatoms. In our previous works [38,45], this energy exchange was taken into account by the decrease in the desorption energy up to the effective value. It is known that, the equilibrium pressure value  $P_0$  is determined by equation [48]:

$$P_0 = A(T_c) \exp\left(-\frac{E_d}{k_B T_c}\right), \quad (1)$$

here  $A(T_c)$  is a coefficient which depends on the condensation temperature  $T_c$ ,  $k_B$  is Boltzmann constant,  $E_d$  is the desorption energy.

Eq. (1) follows that a decrease in the desorption energy to the effective value leads to an increase in the equilibrium pressure value. Therefore, the plasma action onto the growth surface allows to deposit more intense and as a result more controlled vapor fluxes even at low supersaturations. In such a way the stationarity of the deposition process can be increased. In this context, a question arises how the chemically active medium influences the system approaching to the equilibrium. In [38] we have suggested that weakly bounded to the growth surface adatoms may react with other chemical elements and return to vapor state. For example, the adsorbed carbon atoms can be bonded with hydrogen and transform into more volatile hydrocarbon fraction which vaporizes at relatively low temperatures.

In order to provide near-equilibrium conditions for low-volatile substances, chemically active media such as chemically active gases should be used. In this case, re-evaporation of adatoms weakly bound to the growth surface is stimulated by reverse chemical reactions. In other words, the usage of the chemically active medium provides removal of adatoms which are weakly bound with the growth surface, providing selective condensation exclusively on active centers. The influence of the active medium leads to a decrease of the desorption energy up to effective value, and stimulates the approach of the system active medium-condensate to thermodynamic equilibrium conditions.

Quite often similar structures are obtained using absolutely different technologies utilizing plasma-condensate or chemically active medium-condensate systems. An example would be formation of different carbon molecular forms using CVD or PVD technology under near-equilibrium conditions [49–51]. Such similarities in the structures can be explained by identical thermodynamic conditions, which in turn are determined by the same values of the chemical potential difference of atoms in vapor and condensed state.

That is why, the aim of the work, firstly, is to study on the example of copper the nucleation and the growth mechanisms of condensates formation under near-equilibrium conditions implemented in the chemically active medium-condensate system. Secondly, to compare peculiarities of condensate formation mechanisms with our previous results obtained for the plasma-condensate system. We believe that this study will broaden significantly understanding of underlying physical process at condensation under near-equilibrium conditions.

In our previous works [44,52,53] the nucleation and growth of copper layers under near-equilibrium conditions in plasma-condensate system have already been studied. That is why copper has been selected in this work as a material for comparative analysis. It is necessary to point out, that the choice of copper is also caused by wide application of copper-based porous nano-systems as catalytic materials and biosensors [54–59]. Besides that, during the condensation process copper reacts badly with

chemically active residual gases as compared to other metals. This fact is very important at low deposition rates. Thus, according to [60,61] pure copper layers can be formed under near-equilibrium conditions even in oxygen medium. The negligible influence of chemically active gases will allow to understand better peculiarities of the condensation process.

## 2. Methodology of the experiment

### 2.1. Materials

It is known, that decomposition of metallo-organic compounds is often used in order to synthesize metals by CVD. But these metallo-organic precursors are often unstable and can contaminate the resulting layer with carbon and oxygen. One of widespread methods of metals formation by CVD is usage of hydrogen reduction reaction from chlorides. In the case of copper, deposition can be carried out by the hydrogen reduction of the copper I chloride or copper II chloride. In [62] the following reduction reaction is given for CVD copper formation:



In the article [63] the table of known copper precursors for CVD is presented. Among the all precursors both copper I chloride and copper II chloride are listed. Thus,  $\text{CuCl}_2$  and  $\text{CuCl}$  both are well-known precursors.

But  $\text{CuCl}_2$  is one of the most widespread copper compounds after copper sulfite. Its melting temperature is 498 °C and boiling temperature 993 °C. At 1000 °C copper II chloride decomposes into  $\text{CuCl}$  and  $\text{Cl}_2$ . For comparison,  $\text{CuCl}$  has melting point at 426 °C and boiling point at 1490 °C. In our work, the problem was to create extremely weak copper deposition rates. That is why, we have chosen  $\text{CuCl}_2$  as a precursor, because this compound has less amount of copper. As a source  $\text{CuCl}_2$  99.999% purity from the company ABCR was used, the mass of the substance used for one experiment was 8–10 g.

Silicon wafers with (111) orientation were used as substrates. It is known, that under near-equilibrium conditions the structure formation mechanism depends greatly on the growth surface state. That is why silicon substrates with both polished and rough (treated with a sandpaper) surface were used.

### 2.2. Methods

A self-made chemical vapor deposition (CVD) system was used in order to form copper layers. The schematic representation of the system is given in Fig. 1. The main element of the setup is a quartz tube which can sustain high heating temperatures. A tube of smaller diameter having narrowed end was installed inside in order to form a directed flow of a carrier gas. A mixture of hydrogen and nitrogen in ratio 1:3 was used as the carrier gas. The speed of the gas inlet was controlled by means of the flowmeter. The pressure control was installed with purpose to maintain a desired pressure. The vacuum conditions have been created by means of a turbo pump. The CVD setup has three temperature zones identified in Fig. 1 as zone 1, zone 2, zone 3. Different

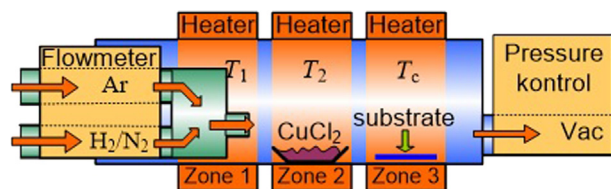


Fig. 1. Schematic representation of CVD device.

temperature values  $T_1$ ,  $T_2$  and  $T_c$  can be maintained in each zone separately with help of the heaters.

The reduction reaction (2) was used in the technological process of copper layers formation. A cuvette with an open top was filled with the copper II chloride powder and placed in the temperature zone 2 (evaporation zone). Evaporated copper II chloride reacted with hydrogen. Copper has been deposited on the substrate positioned in the temperature zone 3 (condensation zone). Hydrogen chloride was removed from the condensation area with the carrier gas flow.

On the first stage of the technological process, the quartz tube was pumped off to the pressure level  $10^{-5}$  Pa. Then high purity argon was introduced into the working area up to the pressure 7500 Pa and heating was started. The argon was used with purpose of the reduction reaction suppressing until the system reaches required temperature regime. When the temperatures in all three zones have reached desired values, argon was pumped out and the working gas mixture  $H_2+N_2$  was introduced into the tube. This moment is considered as the beginning of the deposition process. During the deposition process the  $H_2+N_2$  mixture continuously passed through the reactor and simultaneous pumping maintained pressure at the level 10,000 Pa.

Relatively low evaporation temperatures of  $CuCl_2$  ( $T_2=200$ ,  $350$  °C) were used in order to implement near-equilibrium condensation conditions. Also extremely small copper deposition rates were achieved by adjusting such technological parameters as the condensation temperature  $T_c$ , the carrier gas flow rate  $W$  and the working gas pressure  $P$ . After the deposition process completed, the heating was turned off. Then the working area was pumped off and argon was introduced up to pressure 50,000 Pa. The system was kept in this state until complete cooling down.

### 2.3. Instrumentals

The structure and composition of copper condensates were investigated by scanning electron microscopy equipped with energy dispersive X-ray elemental analysis (SEM, FEI NanoSEM 230) and X-ray diffraction (XRD, SIEMENS (2x) D5000 X-ray diffractometer).

The layers porosity was determined using following methodology; first, the substrate mass ( $m_1$ ) was measured before the deposition. Then, after condensation completed, the mass of the layer and substrate together ( $m_2$ ) was measured. The layers thickness  $d_s$  was determined from SEM cross-section images. The volume of deposited copper layer  $V_{Cu}$  can be calculated using following relation:

$$V_{Cu} = \frac{m_2 - m_1}{\rho_{Cu}} \quad (3)$$

here  $\rho_{Cu}$  is density of copper. The porous layer volume can be determined as:

$$V_c = Sd_s \quad (4)$$

where  $S$  is the porous layer area. Then, the layer porosity can be found as follows:

$$\beta_b = 100\% \frac{V_c - V_{Cu}}{V_c} = 100\% \left( 1 - \frac{m_2 - m_1}{\rho_{Cu} S d} \right) \quad (5)$$

### 3. Results and discussion

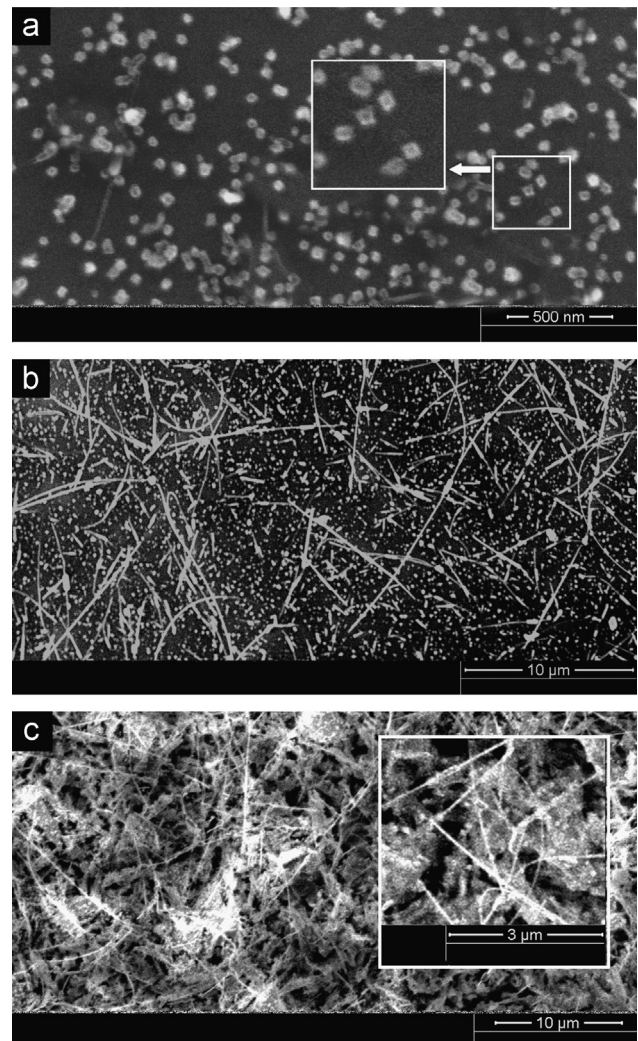
Four sets of experiments have been performed in order to investigate copper structure formation mechanisms under near-equilibrium conditions in a chemically-active medium-condensate system. The deposition parameters of all experiments are presented in the Table 1. It is necessary to point out, that copper was deposited

simultaneously on both mirror polished and rough silicon substrates under the similar technological conditions. The experiments have shown, that the state of the growth surface influences significantly the mechanisms of copper nucleation and growth. At this point, depending on the condensation temperature, a layer-by-layer or a normal crystal growth mechanism can be realized. These two mechanisms correspond to adatoms embedding into an atomically flat or an atomically rough growth surface, respectively. The crystal faceting formation is a characteristic of the layer-by-layer growth mechanism. From the other hand, the normal growth is characterized by round shaped crystals formation [64].

Fig. 2 gives structure of copper layers obtained under technological condition of the first experimental series performed on

**Table 1**  
Technological parameters of copper deposition.

Number of experimental set	$W$ , cm <sup>3</sup> /min	$P$ , Pa	Deposition time, h	$T_1$ , °C	$T_2$ , °C	$T_c$ , °C
1	15.35	10,000	2	350	350	350
2	15.35	10,000	2	350	350	500
3	15.35	10,000	2	200	200	200
4	15.35	10,000	2	200	200	300



**Fig. 2.** The layer-by-layer growth of copper implemented at the temperatures  $T_1=T_2=T_c=350$  °C on the polished (a, b the same structure and different magnifications) and rough (c) silicon surface.

both polished and rough silicon substrates. From SEM images made at different magnifications (Fig. 2a and b) a conclusion can be made about extremely low rates of copper condensation on the polished silicon surface. This fact confirms nearness to thermodynamic equilibrium condensation conditions. The crystal faceting and whiskers for.

The transition from the polished to the rough growth surface under the same technological conditions leads to a significant increase in the copper layer thickness. At the same time, the condensate structure is the same (Fig. 2c). In this case, a highly porous layer is formed consisting of interconnected whiskers and nanoparticles. It is obvious, that more intense crystal growth on the rough growth surface is determined by higher active centers concentration. This fact is a prerequisite for the additional active centers formation and leads to more effective homonucleation of new nanoparticles and whiskers.

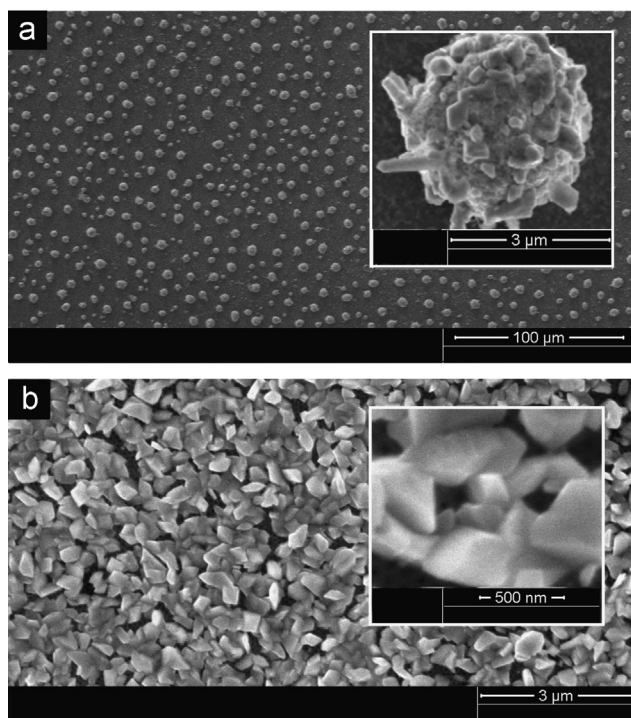
Under technological parameters of the second experimental set and use of polished silicon substrates, relatively large clusters form only on selected areas of the substrate (Fig. 3a). Such selective growth is explained by the preferable nucleation only on limited amount of active centers under Volmer–Weber conditions. The clusters have polycrystalline structure, as a result of rather effective secondary nucleation on already formed copper crystals.

At the identical technological conditions, the rough growth surface usage provides a significant increase in the amount of condensed matter. In this case, the porous structure formed consists of weakly connected with each-other faceted crystals (Fig. 3b). It is necessary to point out, that the increase in the condensation temperature from 350 °C leads to a gradual decrease in the whiskers amount. At the temperatures 500 °C and higher, their formation is not observed at all.

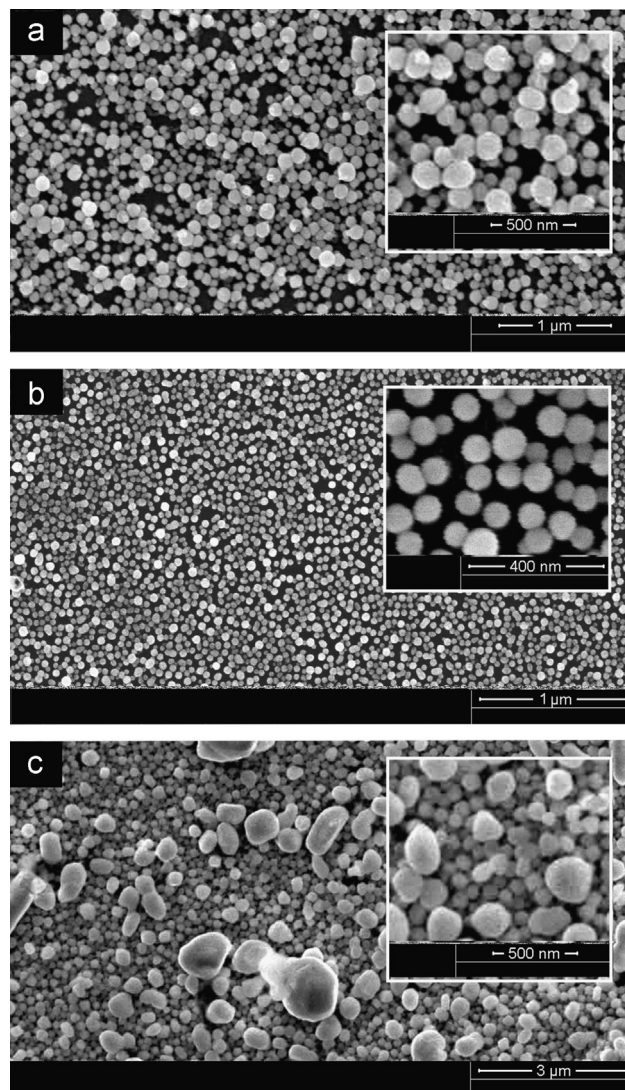
The experimental sets three and four by which the predominant normal crystal growth is implemented deserve a particular attention. At this point atoms embed into atomically rough growth surface. The transition to the normal structure formation mechanism is observed at a decrease in the temperatures in all three zones up to 200 °C. The characteristic feature of this

mechanism is round crystals shape. Fig. 4 gives examples of such structures obtained on the polished (a and b) and rough (c) silicon surface. The same as in previous cases, the crystals growth rate is significantly higher for the rough surface. At the same time, the decrease in the condensation temperature from 300 to 200 °C leads to complete disappearance of the crystal faceting and averaging of the structural elements size (Fig. 4a and b).

The same as for the plasma-condensate system mentioned before, the self-organization of crystals identical size is due to Ostwald ripening process, which intensifies at a decrease in the depositing vapors supersaturation. From the other hand, according to Eq. (1), the equilibrium pressure should decrease at an increase in the condensation temperature  $T_c$  and at all the other conditions being the same it is a prerequisite for the supersaturation increase. This contradiction can be explained by the decrease in the adatoms desorption energy  $E_d$  up to the effective value. The mechanism of this decrease is determined by approaching of the copper reduction reaction (2) to equilibrium conditions. In this case, due to chlorine content excess, the reverse to reduction chemical process can take place which consist in formation of more volatile copper compounds such as CuCl and CuCl<sub>2</sub> and their following evaporation.



**Fig. 3.** The morphology of copper faceted condensates on the polished (a) and rough (b) silicon surface at  $T_1=T_2=350$  °C and  $T_c=500$  °C.



**Fig. 4.** The morphology of copper round shaped condensates formed at  $T_1=T_2=200$  °C on the polished (a –  $T_c=300$  °C, b –  $T_c=200$  °C) and rough (c –  $T_c=200$  °C) silicon surface.

A more rigorous explanation of the change of the structure formation mechanism can be given in terms of the variation in a monatomic step free energy  $\alpha_i$ . In the simplest case, it is determined by equation [64]:

$$\alpha_i = n(E - k_B T_c \ln(1 + 2\chi)) \quad (6)$$

here  $\chi = \exp(-E/k_B T_c)$ ,  $n$  is the density of atoms on the end face of the monatomic step,  $E$  is bonding energies of copper atoms on the monatomic step. At transition from the atomically flat (Fig. 3b) to the atomically rough growth surface (Fig. 4a and b), the monatomic step free energy  $\alpha_i$  becomes zero. Analysis of Eq. (3) shows, that the decrease of  $\alpha_i$  up to zero is observed at an increase in  $T_c$  and decrease in  $E_1$ . The experimental results have shown, that in our case the transition to the atomically rough growth surface occurs at the decrease in the condensation temperature  $T_c$ . It is explained by significant decrease in  $E$  up to effective value due to the reverse chemical processes intensification.

The energy dispersive X-ray elemental analysis shows presence of oxygen in the copper condensates with concentration from 1.4 to 3.5 at%. In the majority of the condensates formed on the polished and rough surface oxygen concentration is the same, and is approximately of about 2 at% (Fig. 5). But with an increase in the porosity and thickness, oxygen concentration rises up to 3.4 at%. In other words, the concentration of oxygen at the top layer is bigger than near the substrate surface. That is why it can be concluded, that presence of oxygen in the condensate is mainly determined by water adsorption and by uppermost layer oxidation after the technological setup opening. The example of such highly porous structure is represented in Fig. 2c.

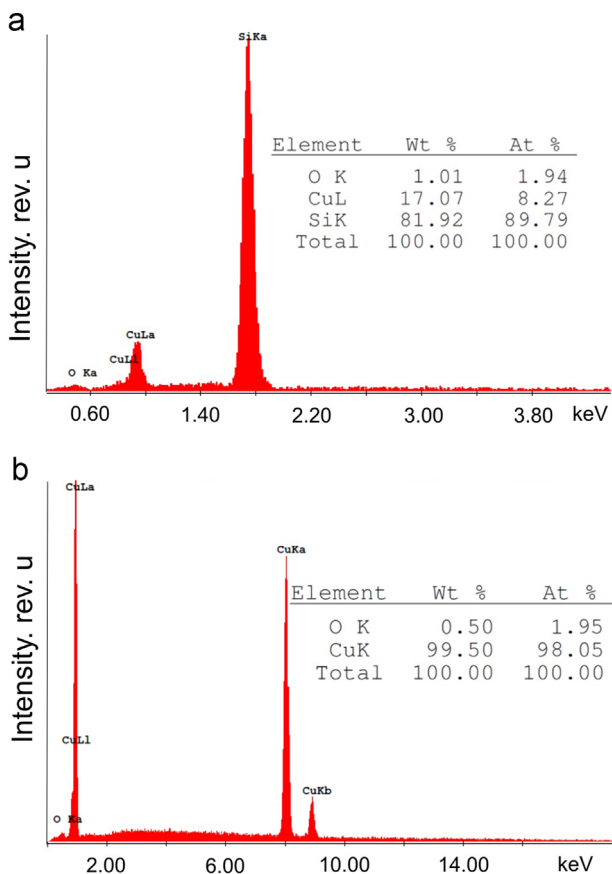


Fig. 5. The elemental analysis results of copper formed on the polished (a – the structure is given in Fig. 3a) and rough (b – the structure is given in Fig. 3b) silicon surface.

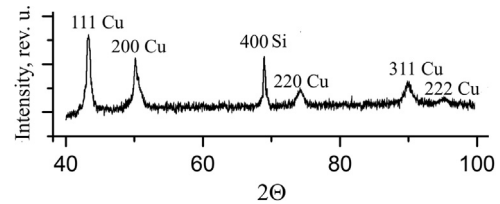


Fig. 6. The XRD pattern of copper layer formed on the rough silicon surfaces (the structure is given in Fig. 3b).

From the other hand oxygen presence in the condensate can be caused by its capture from residual gases during copper condensation. The elemental analysis of the substrate has shown that for the rough growth surface oxygen level can reach from 1.3 to 1.6 at%.

Finally, the condensates phase composition has been investigated. In this case, the analysis of X-ray diffraction patterns has shown that all diffraction maxima correspond to copper. Silicon peak can also be seen. Fig. 6 gives a typical diffraction pattern. The period of crystalline fcc lattice calculated based on the diffraction patterns is 0.3615 nm. This value is in good agreement with the copper lattice parameters.

The described above structure formation mechanisms under near-equilibrium conditions in the chemically active medium-condensate system to the great extent correspond to the structure formation mechanisms in the plasma-condensate system [44,52,53]. For both technological solutions, near-equilibrium condensation allows to implement the transition from layer-by-layer to the normal growth of round shaped crystals together with self-organization of their identical size due to Ostwald ripening. Besides that, the porous structures consisting of weakly bound faceted crystals [53] and round shaped crystals [44,52] can be grown realizing both of these two methods. At the same time, whiskers grow more effectively using CVD technology, but in the plasma-condensate system more morphologically diverse structures with less oxygen content can be formed [53].

Using relation (5) the layers porosity has been calculated. For condensates with structures given in Figs. 2c and 3b the porosity values found to be 65% and 48%, correspondingly for layer's thicknesses from 3.5 to 3.7  $\mu\text{m}$ .

#### 4. Conclusions

1. The possibility of different porous structures formation has been established using near-equilibrium conditions in the chemically active medium-condensate system on the example of copper. The structure formation mechanism is based on such processes as the layer-by-layer or the normal crystal growth, the nucleation and growth of whiskers, and the incomplete intergrowth of the structural elements. In this case, the transition from the layer-by-layer to the normal crystals growth is mainly caused by the decrease in copper adatoms binding energy up to the effective value due to the reverse chemical reactions.
2. The low deposition rates observed for the polished silicon substrates evidence about extremely weak supersaturations of the depositing vapors. The transition to higher deposition rates in case of the rough silicon surface indicates the presence of large amount of active centers for the condensate nucleation. As a result, more effective secondary homonucleation on the already formed copper crystals occurs in this case.
3. From our point of view, the reduction reaction and subsequent homonucleation of copper clusters preferably occurs on the substrate surface. It is known, that thermally isotropic surface

serves as catalyst for chemical reaction initiation. It can be explained by the fact, that probability of adsorbed atoms interaction is higher in the case of their diffusive movement on the substrate surface than in the volume at their motion with directed carrier gas flow. The different deposition rates on the polished and rough growth surface confirm that the reduction reaction do takes place on the substrate. The change of condensate morphology during the deposition process also evidences that the reaction occurs on the surface. For example, in the first set of experiments the layers nucleate in the form of faceted crystals. Then, during more prolonged condensation, whiskers start to grow (Fig. 3). In the case of homonucleation in volume, the condensates must have structure homogeneous with respect to thickness.

- The comparative analysis of the structural and morphological characteristics of copper condensates obtained with help of the chemically active medium-condensate system and the plasma-condensate system has shown the similar growth mechanism. The both technological solutions allow to form round shaped crystals of approximately identical size, which is result of the normal growth and Ostwald ripening. Besides that, the porous structures formation in both cases is a result of the incomplete crystals intergrowth which were selectively nucleated only on active centers. Consequently, the main prerequisite for porous structures formation or system of round shaped crystals formation is realization of near-equilibrium conditions. It is necessary to point out, that the method of implementation of these conditions does not matter. At the same time, the mechanism of approaching to thermodynamic equilibrium for both methods is explained by the decrease in the desorption energy up to the effective value.

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